Search Notes			

Application/Control No.	Applicant(s)/Patent und Reexamination	ler
09/955,945	KAMIWADA ET AL.	•
Examiner	Art Unit	
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SEARCHED			
Class	Subclass	Date	Examiner
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INT	INTERFERENCE SEARCHED			
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
713/168,170,176,193 340/5.2,5.22,5.5,5.54,5.61 (text search only for all - see search history printout)	5/18/2006 (up dated 11/27/06)	(MP)	
EAST (US-PGPUB, USPAT, EPO, JPO, DERWENT, IBM_TDB) - see search history printout	5/18/2006 (11/2-7/06)	(MD (MD)	
NPL (IEEE, GOOGLE)	5/18/2006 (11/27/06)	(MD)	
Inventor Name Search	5/18/2006 . (11/27/06)	(MD)	
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